



US009111827B2

(12) **United States Patent**
Mochiduki

(10) **Patent No.:** **US 9,111,827 B2**
(45) **Date of Patent:** **Aug. 18, 2015**

(54) **MANUFACTURING METHOD OF
SOLID-STATE IMAGING APPARATUS,
SOLID-STATE IMAGING APPARATUS, AND
ELECTRONIC IMAGING APPARATUS**

(71) Applicant: **CANON KABUSHIKI KAISHA,**
Tokyo (JP)

(72) Inventor: **Katsuhisa Mochiduki,** Kawasaki (JP)

(73) Assignee: **CANON KABUSHIKI KAISHA,**
Tokyo (JP)

(*) Notice: Subject to any disclaimer, the term of this
patent is extended or adjusted under 35
U.S.C. 154(b) by 0 days.

(21) Appl. No.: **14/142,219**

(22) Filed: **Dec. 27, 2013**

(65) **Prior Publication Data**

US 2014/0113399 A1 Apr. 24, 2014

Related U.S. Application Data

(63) Continuation of application No. 12/503,888, filed on
Jul. 16, 2009, now Pat. No. 8,643,773.

(30) **Foreign Application Priority Data**

Aug. 19, 2008 (JP) 2008-210528

(51) **Int. Cl.**
H04N 5/225 (2006.01)
G02B 26/02 (2006.01)
H01L 27/146 (2006.01)

(52) **U.S. Cl.**
CPC **H01L 27/14618** (2013.01); **H01L 27/14683**
(2013.01); **H04N 5/2253** (2013.01); **H04N**
5/2254 (2013.01); **Y10T 156/10** (2015.01)

(58) **Field of Classification Search**
CPC H04N 5/2257
USPC 348/207.99; 438/64
See application file for complete search history.

(56) **References Cited**

U.S. PATENT DOCUMENTS

7,582,944 B2 9/2009 Fukuda et al.
7,626,160 B2 * 12/2009 Wu et al. 250/239

(Continued)

FOREIGN PATENT DOCUMENTS

JP	63-131463	8/1988
JP	05-043668 A	6/1993
JP	07-099214	4/1995
JP	2000-333050 A	11/2000
JP	2003-163342 A	6/2003
JP	2005-318483 A	11/2005
JP	2007-299929	11/2007

OTHER PUBLICATIONS

Japanese Communication dated Nov. 16, 2012, issued in connection
with counterpart Japanese Patent Application No. 2008-210528, with
English Translation.

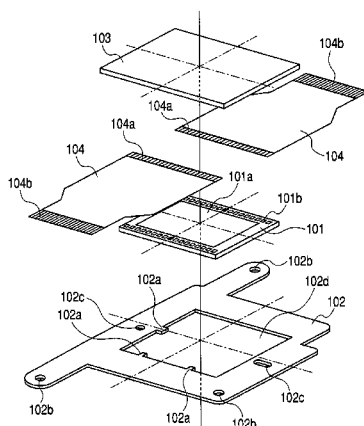
Primary Examiner — Joel Fosselman

(74) *Attorney, Agent, or Firm* — Fitzpatrick, Cella, Harper &
Scinto

(57) **ABSTRACT**

A manufacturing method of a solid-state imaging apparatus includes the steps of: preparing a solid-state imaging device having a light receiving region at a main surface thereof; preparing a light transmitting member having an extending portion extending from the solid-state imaging device; preparing a holding member having a space for holding the solid-state imaging device therein, and having a positioning portion for positioning the solid-state imaging device; fixing the light transmitting member to the main surface of the solid-state imaging device in parallel to each other to keep a constant interval therebetween; bringing a side of the solid-state imaging device to meet the positioning portion of the holding member; and fixing the extending portion of the light transmitting member to the holding member.

19 Claims, 5 Drawing Sheets



(56)

References Cited

U.S. PATENT DOCUMENTS

7,719,600	B2	5/2010	Kaihara et al.	348/335
8,009,222	B2	8/2011	Watanabe et al.	348/340
2002/0195676	A1	12/2002	Hamamoto et al.	257/433
2003/0025824	A1	2/2003	Ishikawa	348/374

2003/0098912	A1	5/2003	Hosokai et al.	348/207.99
2004/0012714	A1	1/2004	Kawai	348/374
2004/0239793	A1 *	12/2004	Lu et al.	348/340
2005/0014307	A1 *	1/2005	Shiraishi et al.	438/60
2007/0215780	A1	9/2007	Eichert et al.	248/497

* cited by examiner

FIG. 1

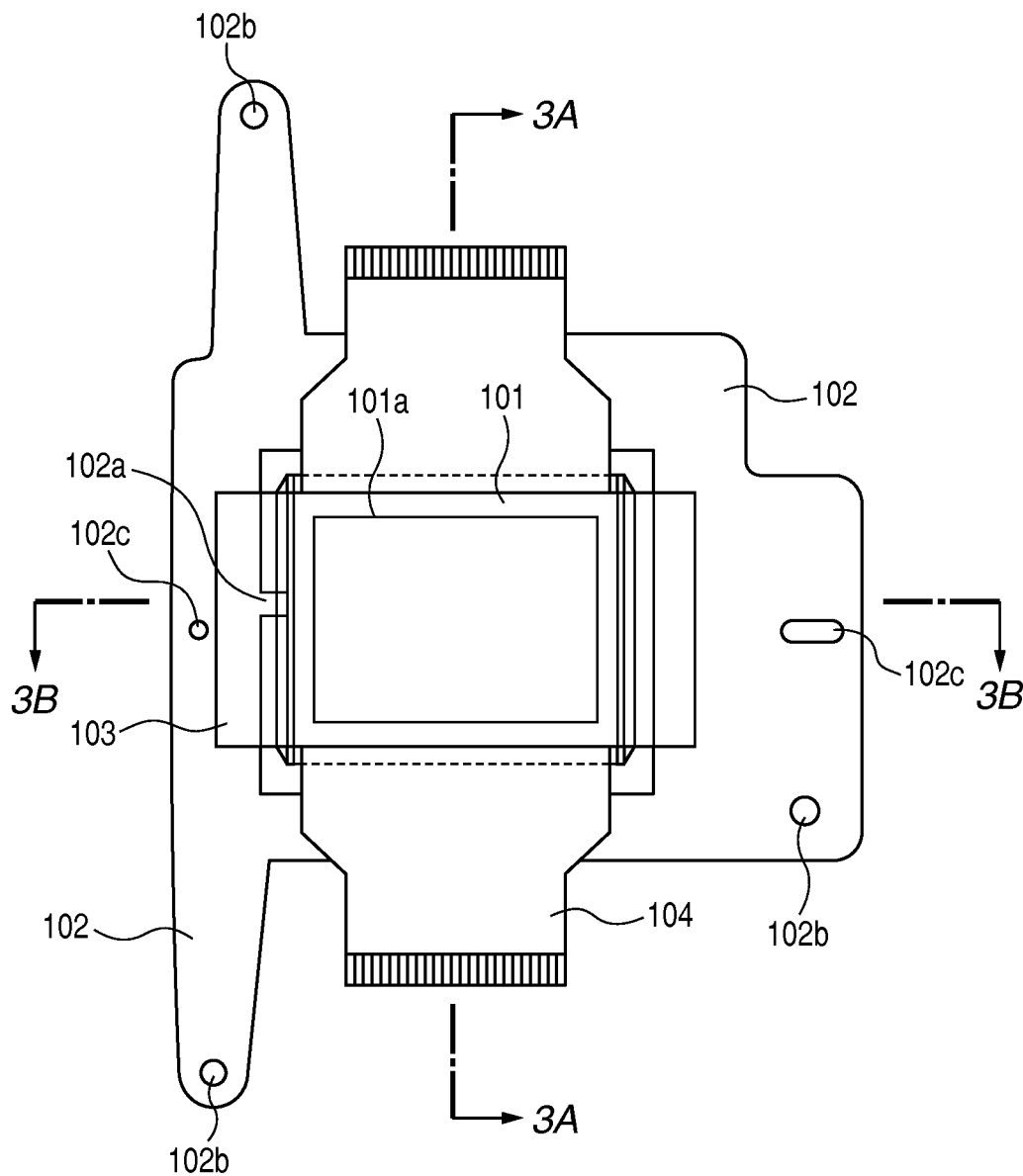


FIG. 2

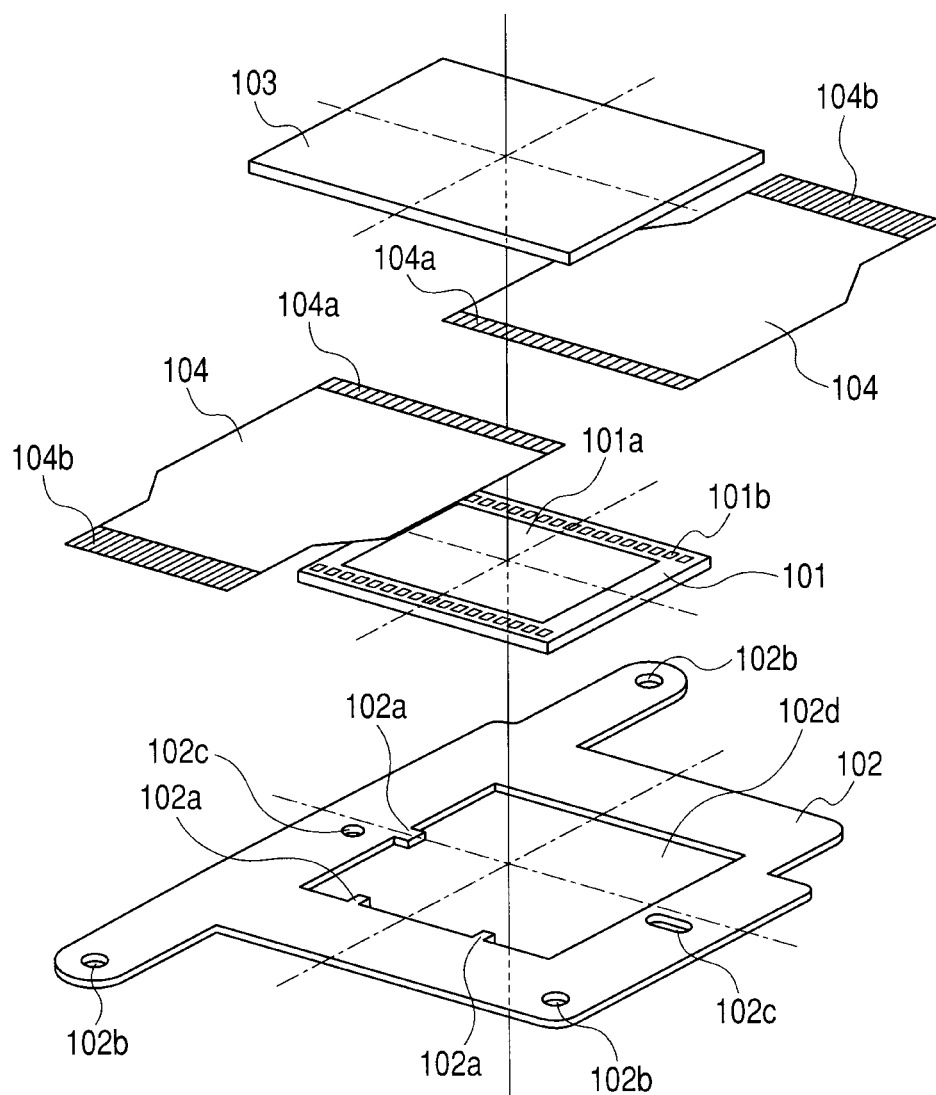


FIG. 3A

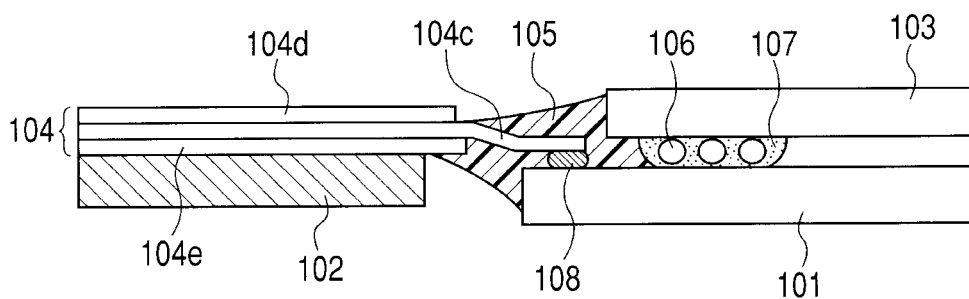


FIG. 3B

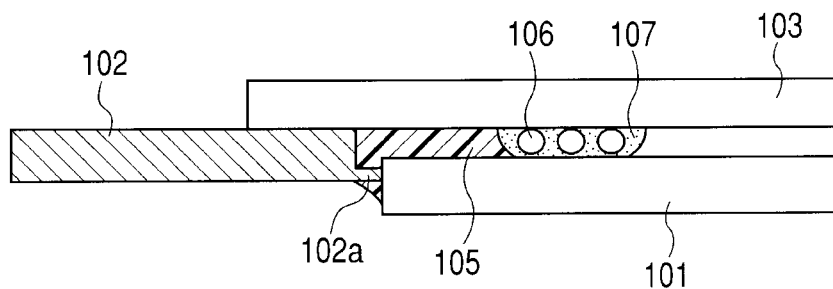


FIG. 4

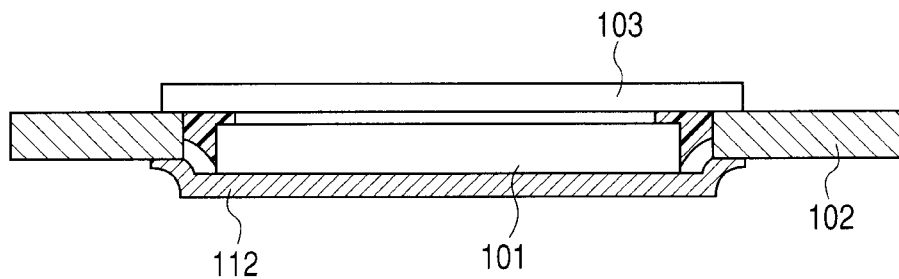


FIG. 5

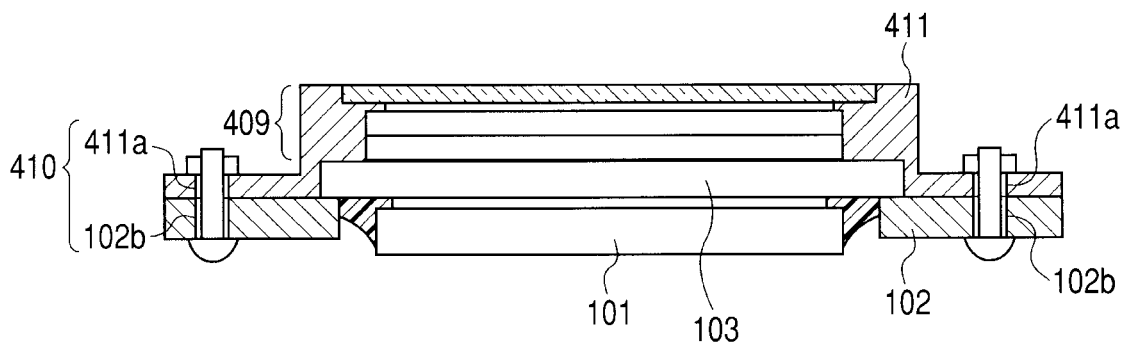
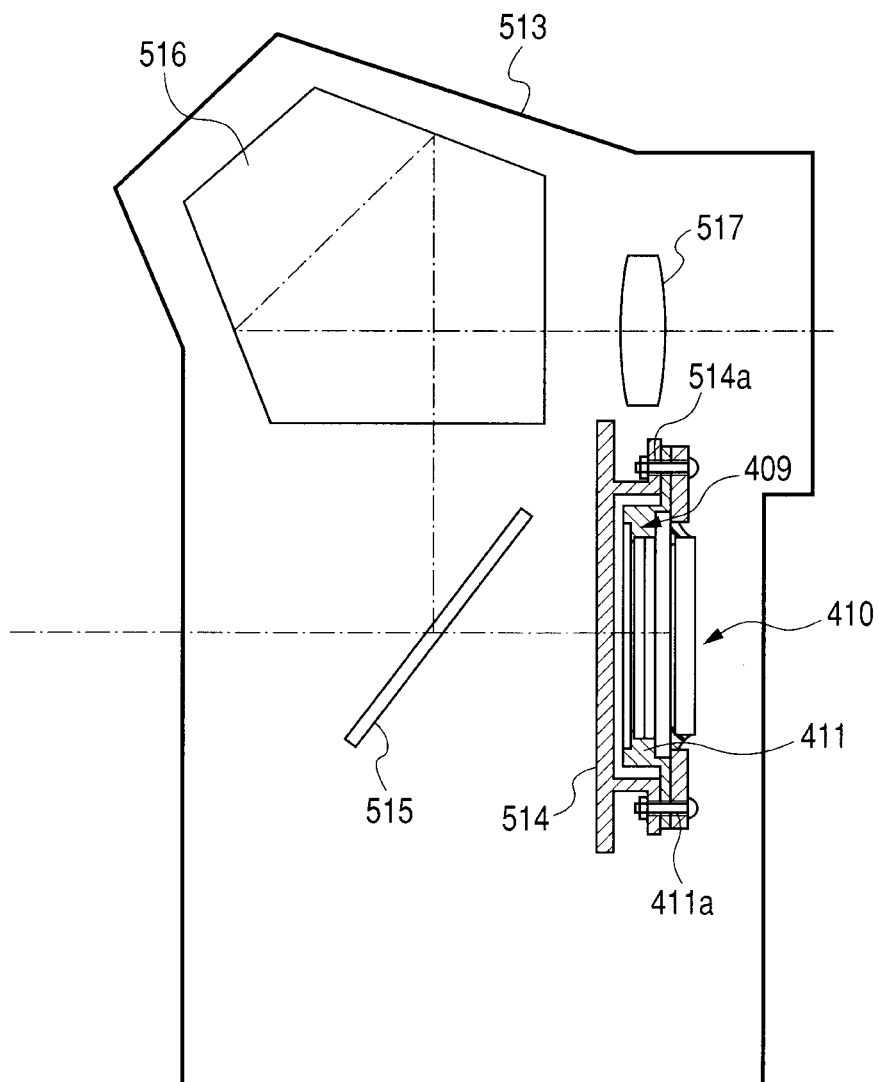


FIG. 6



1

MANUFACTURING METHOD OF SOLID-STATE IMAGING APPARATUS, SOLID-STATE IMAGING APPARATUS, AND ELECTRONIC IMAGING APPARATUS

CROSS-REFERENCE TO RELATED APPLICATIONS

This application is a continuation of U.S. application Ser. No. 12/503,888, filed Jul. 16, 2009, the entire disclosure of which is hereby incorporated herein by reference.

BACKGROUND OF THE INVENTION

1. Field of the Invention

The present invention relates to a manufacturing method of a solid-state imaging apparatus, such as a charge coupled device (CCD) and a complementary metal oxide semiconductor (CMOS), a solid-state imaging apparatus, and an electronic imaging apparatus mounted with the solid-state imaging apparatus.

2. Description of the Related Art

A dual inline package (DIP) and a small outline package (SOP), each made of a ceramic or a resin material, have been widely used as a conventional solid-state imaging apparatus.

A conventional solid-state imaging apparatus is configured so that the electrodes of a solid-state imaging device and the lead frames formed on a package are bonded together with bonding wires, such as Au lines. Moreover, a light transmitting member is made to adhere to a package surface on the light receiving surface side of the solid-state imaging device. It is required for an electronic imaging apparatus, such as a digital camera and a video camera, using this sort of solid-state imaging apparatus to perform an adjustment of a relative positional relation between the solid-state imaging device and an optical viewfinder, and an adjustment of the position of the solid-state imaging device in relation to focusing at the time of assembling the electronic imaging apparatus.

In this adjustment, the following adjustments are necessary: (1) the adjustment of positioning in focusing direction, (2), (3) the adjustments of up, down, left, and right tilts for the prevention of partial blurring, (4), (5) the adjustments in horizontal and vertical directions for field angle adjustment, and (6) tilt and rotation adjustments.

Consequently, at least the adjustments of six axes are needed. One of this sort of solid-state imaging apparatus is disclosed in U.S. Patent Publication No. 2003-0025824 and Japanese Patent Application Laid-Open No. 2000-333050.

SUMMARY OF THE INVENTION

The conventional solid-state imaging apparatus is required to perform the six axis adjustment at the time of being incorporated into an electronic imaging apparatus to every solid-state imaging apparatus, and the adjustments are a step taking a very long operation time. Consequently the cost of the electronic imaging apparatus itself is pushed up.

In the first place, a factor of the necessity of the six axis adjustment resides in a die bonding step of making the solid-state imaging device adhere to the package and fixing it thereto. That is, the factor resides in the limitations of the horizontal resolution, vertical resolution, and rotational resolution of the head of a die bonding apparatus to cause the dispersion of the positions of the solid-state imaging apparatus in the horizontal, vertical, and rotational directions.

Another factor resides in the occurrence of the dispersion of focus in the depth direction and the dispersion of up, down,

2

left, and right tilts of a mounted solid-state imaging device owing to the factors of an individual difference of the size of a package itself, a bend of the die attaching surface of the package, on which a solid-state imaging device is placed, and the like.

It is an object of the present invention to provide a manufacturing method of a solid-state imaging apparatus, a solid-state imaging apparatus, and an electronic imaging apparatus, each capable of eliminating the need of the six axis adjustment taking a long operation time at the time of incorporating the solid-state imaging apparatus into the electronic imaging apparatus to enable the simple and no-time requiring assembly of the solid-state imaging apparatus.

An aspect of the present invention is a manufacturing method of a solid-state imaging apparatus comprising steps of: preparing a solid-state imaging device having a light receiving region at a main surface thereof; preparing a light transmitting member having an area facing the main surface of the solid-state imaging device, and an extending portion extending from the area facing the main surface; preparing a holding member having a space for holding the solid-state imaging device therein, and having a positioning portion for positioning the solid-state imaging device; fixing the light transmitting member to the main surface of the solid-state imaging device in parallel to each other to keep a constant interval therebetween; bringing a side of the solid-state imaging device to meet the positioning portion of the holding member; and fixing the extending portion of the light transmitting member to the holding member.

According to the present invention, the operations of the six axis adjustment, which have been necessary at the time of incorporating a solid-state imaging apparatus into an electronic imaging apparatus, can be rendered unnecessary. Consequently, the assembly operation of the solid-state imaging apparatus can be made remarkably simple, and the electronic imaging apparatus can be manufactured at a low cost.

Further features of the present invention will become apparent from the following description of exemplary embodiments with reference to the attached drawings, in which like reference characters designate the same or similar parts throughout the figures thereof.

BRIEF DESCRIPTION OF THE DRAWINGS

The accompanying drawings, which are incorporated in and constitute a part of the specification, illustrate embodiments of the invention and, together with the description, serve to explain the principles of the invention.

FIG. 1 is a plan view illustrating an embodiment of a solid-state imaging apparatus according to the present invention.

FIG. 2 is an exploded perspective view of the solid-state imaging apparatus of FIG. 1.

FIG. 3A is a sectional view taken along the line 3A-3A of FIG. 1.

FIG. 3B is a sectional view taken along the line 3B-3B of FIG. 1.

FIG. 4 is a sectional view illustrating an embodiment of a solid-state imaging apparatus of the present invention with a protecting member covering the back surface of the solid-state imaging apparatus.

FIG. 5 is a sectional view illustrating a solid-state imaging unit according to the present invention.

FIG. 6 is a schematic view illustrating an embodiment of an electronic imaging apparatus mounted with a solid-state imaging unit according to the present invention.

DESCRIPTION OF THE EMBODIMENTS

In the following, exemplary embodiments for implementing the present invention will be described in detail with reference to the attached drawings.

FIG. 1 is a plan view illustrating an embodiment of a solid-state imaging apparatus according to the present invention. FIG. 2 is an exploded perspective view illustrating each part constituting the solid-state imaging apparatus in an exploded state. FIG. 3A is a sectional view taken along the line 3A-3A of FIG. 1, and FIG. 3B is a sectional view taken along the line 3B-3B of FIG. 1. FIG. 3A illustrates the bonding portion of the solid-state imaging device with a wiring substrate in detail.

In FIGS. 1 to 3B, a light receiving region **101a** is formed on a main surface of a solid-state imaging device **101**, such as a CCD or a CMOS. Electrodes **101b** contributing to input and output signals of the solid-state imaging device **101** are formed in regions of the peripheral portions of the light receiving region **101a** of the solid-state imaging device **101** over both of the opposing sides thereof. A light transmitting member **103** is arranged over the upper surface of the solid-state imaging device **101**. As the light transmitting member **103** bonded to the solid-state imaging device **101**, mainly glass or crystal is used, and the light transmitting member **103** is arranged over the light receiving surface of the solid-state imaging device **101** with a constant interval between them.

As the method of arranging the light receiving surface of the solid-state imaging device **101** and the light transmitting member **103** in parallel to each other with the constant interval between them, no especial limitations exist. For example, as illustrated in FIGS. 3A and 3B, there is a method of using spherical spacers **106**. Moreover, it can be easily realized to arrange the light receiving surface of the solid-state imaging device **101** and the light transmitting member **103** in parallel to each other with the constant interval between them by using columnar spacers (not illustrated).

Furthermore, by making an adhesive **107** intervene in the surroundings of the spacers **106**, the solid-state imaging device **101** and the light transmitting member **103** can be easily made to adhere to each other with the constant interval kept between them. The spacers **106** and the adhesive **107** are uniformly formed over four sides of the solid-state imaging device **101**, and are arranged lest they should enter the light receiving region **101a** of the solid-state imaging device **101**.

In the configuration described above, the solid-state imaging device **101** and the light transmitting member **103** are arranged in parallel to each other with the constant interval between them, and consequently both of the parallelism between the light receiving surface of the solid-state imaging device **101** and the light transmitting member **103** and the distance between the light receiving surface of the solid-state imaging device **101** and the light transmitting member **103** can be secured to be constant. The light transmitting member **103** is structured to make at least a part thereof extend from the solid-state imaging device **101**. That is, it is important to form at least a part of the light transmitting member **103** to be larger than the size of the solid-state imaging device **101**. By extending at least a part of the light transmitting member **103** in this way and by using the extending part for bonding the light transmitting member **103** with a holding member **102**, described below, the positional accuracy of the light transmitting member **103** can be easily secured.

Moreover, the whole of the light transmitting member **103** may be larger than the solid-state imaging device **101**. In this case, the size of the light transmitting member **103** on the sides of both the opposing sides of the light transmitting

member **103** on which sides the electrodes **101b** are not formed on the solid-state imaging device **101** is preferably made to be larger than the size of the solid-state imaging device **101** if the electrodes **101b** are formed on both of the opposing sides of the solid-state imaging device **101** as illustrated in FIGS. 1 and 2. Moreover, the light transmitting member **103** is more preferably shaped to situate its end faces between the electrodes **101b** of the solid-state imaging device **101** and the light receiving region **101a** on the sides of both of opposing sides on which the electrodes **101b** are formed.

By shaping the light transmitting member **103** in this shape, the electrodes **101b** are exposed after the light transmitting member **103** has been arranged over the solid-state imaging device **101**, and consequently wiring substrates **104** can be attached after the adhesion of the light transmitting member **103**. It is no doubt possible to attach the wiring substrates **104** before the arrangement of the light transmitting member **103**, but by arranging the light transmitting member **103** beforehand, the time during which the solid-state imaging device **101** is exposed to the assembling environment can be shortened. Consequently, particles and the like that adhere to the light receiving region **101a** of the solid-state imaging device **101** can be prevented.

The thickness of the light transmitting member **103** is not especially limited, but the thicknesses from 0.1 mm to 2.0 mm are suitably used. Each of the wiring substrates **104** is made of a flexible printed circuit board of the structure in which a conductive foil **104c** made of Cu or the like is laminated on a base film **104e** made of polyimide or the like and the conductive foil **104c** is protected by being covered by an insulator **104d**, such as solder resist, except for a terminal portion and a soldering portion as illustrated in FIG. 3A.

Inner leads **104a** wired at the same pitches as those of the electrodes **101b** formed on the solid-state imaging device **101** are formed on the conductive foil **104c**, which is electrically bonded to the electrodes **101b** of the solid-state imaging device **101**, as illustrated in FIG. 2. Outer leads **104b** are formed on the outer side of the wiring substrate **104**, where electrical bonding to a not illustrated substrate of an electronic imaging apparatus body is performed.

Stud bumps **108** made of Au or the like are formed on the electrodes **101b** formed on the solid-state imaging device **101** for bonding the electrodes **101b** with the inner leads **104a** of the wiring substrate **104** as illustrated in FIG. 3A. It is preferable to perform planarization processing to the upper surfaces of the stud bumps **108** in order to make the bonding of the stud bumps **108** with the inner leads **104a** easy. After the relative positions of the stud bumps **108** to the inner leads **104a** have been adjusted, the electrodes **101b** and the inner leads **104a** are electrically bonded together by gang bonding, single point bonding, or the like.

After the light transmitting member **103** and the wiring substrates **104** have been attached to the solid-state imaging device **101**, the holding member **102** is attached to the solid-state imaging device **101**. The holding member **102** has a space **102d** capable of holding the light transmitting member **103** therein and at the same time holding the solid-state imaging device **101** therein as illustrated in FIG. 2. Moreover, the holding member **102** is a part having positioning portions **102a** for positioning the solid-state imaging device **101**. In the following, the holding member **102** will be described in detail.

As illustrated in FIG. 2, the holding member **102** is a plate-like member forming the space **102d** capable of holding the solid-state imaging device **101** therein at the center of the holding member **102**. The positioning portions **102a** are formed on the holding member **102**. The positioning portions

5

102a are integrated with the holding member **102**, and are provided at three points of the holding member **102** so as to be projected into the space **102d** as protrusions.

As a material for forming the holding member **102**, a material having rigidity and being realizable of the dimensional accuracy of, for example, $\pm 50 \mu\text{m}$ or less is suitable. Also as to the planarity of the material, the one realizable the processing accuracy of $\pm 30 \mu\text{m}$ or less is suitable. More suitably, the planarity is $\pm 10 \mu\text{m}$ or less. As the materials capable of acquiring these characteristics, the materials, such as plastic and metal, can be suitably selected.

In the case of plastic, the materials having rigidity are suitable, and for example, polycarbonate (PC), acrylonitrile butadiene styrene (ABS), POW, polypropylene (PP), polyethylene (PE), and PPEE are suitable. However, the materials are not limited to those listed in the above. Moreover, it is preferable that the materials have conductivity from the point of view of electro-static destruction.

In the case of metal, as the quality of material, for example, iron-nickel alloys, such as 42 alloy, 50 alloy, permalloy, Kovar, and Invar, and stainless steel, such as, stainless steel (SUS) **430**, and SUS **304**, are suitable, but the metals are not limited especially to the above-listed ones. It is also possible to suppress the surface roughness and the planarity to a desired extent or less by performing grinding, lapping, or the like, after a desired shape has been acquired by press working. In case of using a metal material, because the metal material has high conductivity, the influences of electro-static destruction can be prevented that much at the time of contact with the solid-state imaging device **101**, and the metal material is more suitable.

The solid-state imaging device **101** and the light transmitting member **103**, which are arranged in parallel to each other as described above, are attached to this holding member **102**. The attachment method is to bring the side of the solid-state imaging device **101** to the positioning portions **102a** (the positioning portions **102a** at three positions illustrated in FIG. **2** in the present embodiment) to meet the side to the positioning portions **102a**. At the same time, bonding is performed with the adhesion surface side of an extending portion of the light transmitting member **103** to the solid-state imaging device **101** close to the holding member **102** (see FIG. **3B**). In this case, as illustrated in FIGS. **3A** and **3B**, the light transmitting member **103** may be made to adhere to the holding member **102** with a sealing resin **105**, or the light transmitting member **103** may be made to adhere to the holding member **102** with an adhesive separately.

By adopting this configuration, the light transmitting member **103** can be attached to the holding member **102** in parallel to it. Because the light transmitting member **103** and the solid-state imaging device **101** have already been bonded together in parallel to each other, the position (position in focusing direction) of the solid-state imaging device **101** to the holding member **102** can be made to be constant. Moreover, the positions of the up, down, left, and right tilts can be made to be always constant in order to preventing partial blurring.

That is, by bonding the light transmitting member **103** and the solid-state imaging device **101** together on the basis of the holding member **102** while keeping the light transmitting member **103** and the solid-state imaging device **101** in parallel to each other, the adjustment of the position of the solid-state imaging device **101** to the holding member **102** in the focusing direction (Z direction) . . . (1) is completed. At the same time, the adjustments of the three axes of the up, down, left, and right tilts . . . (2), (3) are completed.

6

Furthermore, since the bonding of the solid-state imaging device **101** to the light transmitting member **103** is performed by contacting the side of the solid state imaging device **101** bonded to the light transmitting member **103** with the positioning portions **102a** formed on the holding member **102** (bringing the side to meet the positioning portions **102a**), the positions of the solid-state imaging device **101** to the holding member **102** in the horizontal and vertical directions and in the tilt and rotational directions can be always made to be constant. That is, the adjustments in three axes in the horizontal and vertical directions (X and Y directions) . . . (4), (5), and the rotational direction (θ) . . . (6) can be completed. These adjustments in the six directions (1)-(6) are the same as those described in the clause of Description of the Related Art.

At this time point the structure of the present invention is in the state in which all of the six axis adjustment of the solid-state imaging device **101** to the holding member **102** have been completed. Moreover, it is desirable to form a fixing unit including at least a holding hole in the holding member **102**. Moreover, one or more positioning holes may be formed in the holding member **102** in addition to the holding hole.

Positioning holes **102c** and holding holes **102b** are formed in the holding member **102** as illustrated in FIGS. **1** and **2** in the present embodiment, which is an example of the formation of two positioning holes **102c** and three holding holes **102b**. These holes can be formed in the holding member **102** accurately by publicly known drilling or punching.

Consequently, the position of the solid-state imaging device **101** can be uniquely determined to the positions of the holding holes **102b** of the holding member **102**, and the solid-state imaging apparatus always keeping a fixed state positional relation can be provided.

Moreover, the fixing unit (holding holes **102b**) is formed on the side of the solid-state imaging apparatus, and the bonding portion (holding holes or the like) corresponding to the fixing unit is accurately formed on the side of the electronic imaging apparatus, such as a digital camera and a digital video camera. By the formation of these fixing units and bonding portion, desired accuracy of the solid-state imaging apparatus to the electronic imaging apparatus can be easily acquired only by bonding the solid-state imaging apparatus of the present invention to the electronic imaging apparatus by the use of the fixing unit.

At this time, as described above, the six axis adjustment of the solid-state imaging device **101** to the holding member **102** have been completed. Consequently, by incorporating the solid-state imaging apparatus of the present invention into the electronic imaging apparatus by the use of the fixing unit (holding holes **102b**) formed in the holding member **102**, the solid-state imaging apparatus can be simply incorporated without performing the six axis adjustment.

The sealing resin **105** illustrated in FIGS. **3A** and **3B** is formed to cover the outer periphery of the spacers **106** and adhesive **107** here. Moreover, although it is not illustrated, the sealing resin **105** may be formed to completely cover the back surface (non-light receiving surface side) of the solid-state imaging device **101**. The sealing resin **105** is, for example, the one made of an epoxy resin having an excellent moisture resistance, and no limitations to the sealing resin **105** exist especially. But a sealing resin of the type of being cured by heat, an ultraviolet ray, or concomitant use of both of them is suitable.

By forming the sealing resin **105** in such a way, the moisture resistance of the solid-state imaging device **101** and the reliability of the mechanical and electrical bonding of the conductive foil **104c**, which is a bonding portion member,

can be improved. As a unit covering the back surface of the solid-state imaging device **101**, a protecting member **112** (illustrated in FIG. **4**) may be made to adhere to the back surface in addition to the method of using the sealing resin **105**.

FIG. **4** is a sectional view illustrating an embodiment covering the back surface (non-light receiving surface side) of the solid-state imaging device **101** with the protecting member **112**. In FIG. **4**, the same parts as those in FIGS. **1** and **2** are denoted by the same reference characters as those of FIGS. **1** and **2**. The material of the protecting member **112** is not especially limited, but, for example, iron-nickel alloys, such as 42 alloy, 50 alloy, permalloy, Kovar, and Invar, and stainless steel metals, such as SUS **430** and SUS **304**, each having high thermal conductivity, are suitably used. By using the material having the high thermal conductivity, the material can also assume the role of a radiator plate.

Moreover, although the protecting member **112** is made to adhere to the holding member **102**, it is preferable to make the back surface of the solid-state imaging device **101** adhere to the protecting member **112** by the use of an adhesive having high thermal conductivity in the case of aiming both of the protection and heat radiation of the solid-state imaging device **101**.

Although the solid-state imaging apparatus of the present invention is sometimes fixed to an electronic imaging apparatus by being directly attached thereto, the similar advantages can be acquired also by attaching the solid-state imaging apparatus to another unit part once and then by fixing solid-state imaging apparatus to the electronic imaging apparatus by fixing the unit part thereto. Although the unit part is not especially limited, for example, a unit part including an optical part, such as an optical low-pass filter, mounted on the solid-state imaging apparatus of the present invention can be given.

FIG. **5** illustrates an example of a unit (hereinafter referred to as solid-state imaging unit) including an optical part, such as the optical low-pass filter, placed on a solid-state imaging apparatus. In FIG. **5**, the same parts as those illustrated in FIGS. **1** to **4** are denoted by the same reference characters as those of FIGS. **1** to **4**. In FIG. **5**, the optical low-pass filter **409** is mounted on the solid-state imaging apparatus of the present invention. The solid-state imaging unit **410** includes the solid-state imaging apparatus and the optical low-pass filter **409**. The filter **409** includes an infrared cut filter composed of an infrared absorbing glass and a dichroic mirror, and a low-pass filter composed of a separating plate separating a subject image into a horizontal direction and a vertical direction and a phase plate.

The optical low-pass filter **409** is fixed to an optical low-pass filter holding member **411**, in which holding holes **411a** are formed at the positions corresponding to the holding holes **102b** formed in the solid-state imaging apparatus.

The optical low-pass filter holding member **411** equipped with the optical low-pass filter **409** is bonded to the solid-state imaging apparatus by adjusting the relative positions of the holding holes **102b** and **411a** on the basis of the holding member **102** of the solid-state imaging apparatus. By forming the optical low-pass filter holding member **411** with accuracy, a fixed state positional relation between the solid-state imaging apparatus and the optical low-pass filter **409** can be held in the solid-state imaging unit **410**.

FIG. **6** is a view illustrating an example of incorporating the solid-state imaging unit **410** illustrated in FIG. **5** into a camera (electronic imaging apparatus). In FIG. **6**, the same parts as those in FIG. **5** are denoted by the same reference characters as those in FIG. **5**. In FIG. **6**, the camera includes a camera

body **513**, a shutter unit **514**, and a mirror **515**, which is obliquely provided in the imaging path or withdraws therefrom according to an observation state and an imaging state, respectively.

In the observation state, the mirror **515** is in the state of being obliquely provided in the imaging optical path, and advances a light bundle reflected on the mirror **515** toward the upper part of the camera body **513**. The reflected light bundle passes through a penta-prism **516** and a finder optical system **517** to enable an observation image to be observed on the finder.

Moreover, in the imaging state the mirror **515** is in the state of withdrawing from the imaging optical path, and the light bundle enters the solid-state imaging unit **410** through the optical low-pass filter **409**, constituting the solid-state imaging unit **410**, during the shutter unit **514** is opened.

The solid-state imaging unit **410** is bonded to the shutter unit **514** constituting a part of the camera body **513**. Holding holes **514a** for bonding the solid-state imaging unit **410** are formed in the shutter unit **514** at the positions thereof corresponding to the holding holes **102b** of the solid-state imaging apparatus. Although the relative positional relations of the holding holes **514a** to the holding holes **411a** formed in the optical low-pass filter holding member **411** may not be the same, the relative positional relations may be made to be the same. In this case, the optical low-pass filter holding member **411** and the shutter unit **514** can be fixed to the solid-state imaging apparatus all together.

If the bonded side of the solid-state imaging unit **410** has been produced with accuracy, the optical system of the camera can be configured with accuracy only by fixing the solid-state imaging unit **410** even when the solid-state imaging unit **410** is incorporated into the camera body **513**, and no adjustments are especially required. That is, the six axis adjustment of the solid-state imaging device to the holding member **102** have been completed, and consequently the adjustment of the relative positional relation between the solid-state imaging device **101** and the optical viewfinder and the adjustment of the imaging focusing direction are rendered to be unnecessary even when the solid-state imaging unit **410** is incorporated in the camera body **513**. Consequently, adjustment steps can be reduced to a large extent, and inexpensive electronic imaging apparatus can be provided.

As many apparently widely different embodiments of the present invention can be made without departing from the spirit and scope thereof, it is to be understood that the invention is not limited to the specific embodiments thereof except as defined in the claims.

This application claims priority from Japanese Patent Application No. 2008-210528 filed on Aug. 19, 2008, which is hereby incorporated by reference herein.

What is claimed is:

1. A solid-state imaging apparatus, comprising:
 - a solid-state imaging device including a light receiving region in a main face of the solid-state imaging device;
 - a light transmitting member provided at a position apart from the light receiving region and including an extending portion which is at least a part of the light transmitting member and is extended from the solid-state imaging device; and
 - a holding member for holding the light transmitting member and including a space where the solid-state imaging device is arranged, wherein
 - a lower face of the extending portion of the light transmitting member is fixed to an upper face of a portion surrounding the space of the holding member,

9

the portion surrounding the space of the holding member includes a positioning portion projected into the space, and

a side of the solid-state imaging device is in contact with the positioning portion.

2. The solid-state imaging apparatus according to claim 1, wherein the lower face of the extending portion of the light transmitting member is fixed to the main face of the solid-state imaging device.

3. The solid-state imaging apparatus according to claim 2, wherein a spacer member and an adhesive are formed between the lower face of the extending portion of the light transmitting member and the main face of the solid-state imaging device.

4. The solid-state imaging apparatus according to claim 1, wherein

the solid-state imaging device includes electrodes formed on the main face of an outside of the light receiving region, and

the solid-state imaging apparatus further comprises a wiring substrate connected to the electrodes.

5. The solid-state imaging apparatus according to claim 4, wherein

the lower face of the extending portion of the light transmitting member is fixed to the main face of the solid-state imaging device, and

an adhesive adhering the lower face of the extending portion of the light transmitting member to the main face of the solid-state imaging device is positioned between the light receiving region and the electrodes.

6. The solid-state imaging apparatus according to claim 1, wherein the main face comprises electrodes formed in a region outside of its light receiving region on two sides opposing to each other across the light receiving region.

7. The solid-state imaging apparatus according to claim 6, wherein the extending portion of the light transmitting member is positioned at least above a side where the electrodes are not formed.

8. The solid-state imaging apparatus according to claim 1, wherein the main face comprises electrodes formed in a region outside of the light receiving region with a wiring substrate connected to the electrodes, the wiring substrate being provided from the main face of the solid-state imaging device to the upper face of the portion surrounding the space of the holding member.

9. The solid-state imaging apparatus according to claim 1, wherein the lower face of the extending portion of the light transmitting member and the upper face of the portion surrounding the space of the holding member are in contact with each other.

10. The solid-state imaging apparatus according to claim 1, wherein the portion surrounding the space includes a second positioning portion, which is other than the positioning portion, projected into the space.

11. The solid-state imaging apparatus according to claim 1, wherein in a certain direction, the space is larger than the solid-state imaging device and the light transmitting member is larger than the space.

12. The solid-state imaging apparatus according to claim 1, wherein the holding member is formed from an iron-nickel alloy or a stainless steel.

13. The solid-state imaging apparatus according to claim 1, wherein the holding member has a plate-like shape.

14. The solid-state imaging apparatus according to claim 1, wherein a holding hole is formed in the holding member.

10

15. The solid-state imaging apparatus according to claim 14, wherein

the solid-state imaging apparatus is fixed by the holding hole, or

a solid-state imaging apparatus unit including the solid-state imaging apparatus is fixed by the holding hole.

16. The solid-state imaging apparatus according to claim 14, further comprising a filter.

17. A solid-state imaging apparatus comprising:

a solid-state imaging device; a light transmitting member having at least a part extending from the solid-state imaging device; and a holding member holding the light transmitting member, wherein

the light transmitting member is fixed in parallel to a light receiving face of the solid-state imaging device to keep a constant interval therebetween,

the holding member includes a space and a positioning portion for positioning the solid-state imaging device, the solid-state imaging device is arranged in the space, a side of the solid-state imaging device is brought to meet the positioning portion of the holding member, an extending portion of the light transmitting member is fixed to the holding member,

electrodes are formed on two sides opposing to each other of the solid-state imaging device,

the light transmitting member and the solid-state imaging device is fixed by an adhesive, and

the adhesive fixing the light transmitting member and the solid-state imaging device is positioned between the light receiving face of the solid-state imaging device and the electrodes.

18. A solid-state imaging apparatus comprising:

a solid-state imaging device; a light transmitting member having at least a part extending from the solid-state imaging device; and a holding member holding the light transmitting member, wherein

the light transmitting member is fixed in parallel to a light receiving face of the solid-state imaging device to keep a constant interval therebetween,

the holding member includes a space and a positioning portion for positioning the solid-state imaging device, the solid-state imaging device is arranged in the space, a side of the solid-state imaging device is brought to meet the positioning portion of the holding member, an extending portion of the light transmitting member is fixed to the holding member,

electrodes are formed on two sides opposing to each other of the solid-state imaging device, and

the light transmitting member includes the extending portion formed at least on a side where the electrodes are not formed.

19. A solid-state imaging apparatus comprising:

a solid-state imaging device; a light transmitting member having at least a part extending from the solid-state imaging device; and a holding member holding the light transmitting member, wherein

the light transmitting member is fixed in parallel to a light receiving face of the solid-state imaging device to keep a constant interval therebetween,

the holding member includes a space and a positioning portion for positioning the solid-state imaging device, the solid-state imaging device is arranged in the space, a side of the solid-state imaging device is brought to meet the positioning portion of the holding member, an extending portion of the light transmitting member is fixed to the holding member, and

the holding member includes a holding hole.